Displaytech a seacomp company

Character LCD Module Product Specification

204G BC BW

20 Characters X 4 Lines STN Y/G LCD, Y/G Lightbox, 6 o'clock, Wide Temperature

August 2, 2019

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Revision Record

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1. General Specification

Item	Dimension	Unit
Number of Characters	20 Characters x 4 Line	-
Module dimension	98.0x60.0x13.6(MAX)	mm
View area	77.0x25.2	mm
Active area	70.4x20.8	mm
Dot size	0.55x0.55	mm
Dot pitch	0.60x0.60	mm
Character size	2.95x4.75	mm
Character Pitch	3.55x5.35	mm
LCD type	STN, Positive, Transflective, Yell (In LCD production, It will occur s can only guarantee the same col	slightly color difference. We
Duty	1/16	
View direction	6 o'clock	
Backlight Type	LED Yellow Green	

2. Absolute Maximum Ratings

Item	Symbol	Min	Тур	Max	Unit
Operating Temperature	T _{OP}	-20	-	+70	°C
Storage Temperature	T _{ST}	-30	-	+80	°C
Input Voltage	Vı	V_{SS}	-	V_{DD}	V
Supply Voltage For Logic	V_{DD} - V_{SS}	-0.3	-	7	V
Supply Voltage For LCD	V _{DD} -V ₀	-0.3	-	13	V

3. Electrical Characteristics

ltem	Symbol	Condition	Min	Тур	Max	Unit
Supply Voltage for Logic	V_{DD} - V_{SS}	-	4.5	5.0	5.5	V
		Ta=20 ℃	-	-	5.3	V
Supply Voltage For LCD *Note	V_{DD} - V_0	Ta=25 ℃	-	4.2	-	V
		Ta=70 ℃	3.8	-	-	V
Input High Volt.	V _{IH}	-	$0.7 V_{DD}$	-	V_{DD}	V
Input Low Volt.	V _{IL}	-	V _{SS}	-	0.6	V
Output High Volt.	V _{он}	-	3.9	-	-	V
Output Low Volt.	V _{OL}	-	-	-	0.4	V
Supply Current	I _{DD}	V _{DD} =5.0V	1.0	1.2	1.5	mA

* Note: Please design the VOP adjustment circuit on customer's main board



4. Optical Characteristics

Item	Symbol	Condition	Min	Тур	Max	Unit
View Angle	(V)θ	CR≧2	20	-	40	deg
View Aligie	(H)φ	CR≧2	-30	-	30	deg
Contrast Ratio	CR	-	-	3	-	-
Response Time	T rise	-	-	150	200	ms
	T fall	-	-	150	200	ms

Definition of Operation Voltage (Vop)



Definition of Response Time (Tr, Tf)



Conditions:

Operating Voltage : Vop Frame Frequency: 64 HZ Viewing Angle(θ , ϕ) : 0° , 0° Driving Waveform: 1/N duty, 1/a bias

Definition of viewing angle(CR \ge 2)



5. Interface Pin Function

Pin No.	Symbol	Level	Description
1	V _{SS}	0V	Ground
2	V _{DD}	5.0V	Supply Voltage for logic
3	VO	(Variable)	Operating voltage for LCD
4	RS	H/L	H: DATA, L: Instruction code
5	R/W	H/L	H: Read(MPU→Module) L: Write(MPU→Module)
6	E	H.H→L	Chip enable signal
7	DB0	H/L	Data bus line
8	DB1	H/L	Data bus line
9	DB2	H/L	Data bus line
10	DB3	H/L	Data bus line
11	DB4	H/L	Data bus line
12	DB5	H/L	Data bus line
13	DB6	H/L	Data bus line
14	DB7	H/L	Data bus line
15	A	-	LED +
16	К	-	LED -

6. Contour Drawing & Block Diagram





7. Function Description

The LCD display Module is built in a LSI controller, the controller has two 8-bit registers, an instruction register (IR) and a data register (DR).

The IR stores instruction codes, such as display clear and cursor shift, and address information for display data RAM (DDRAM) and character generator (CGRAM). The IR can only be written from the MPU. The DR temporarily stores data to be written or read from DDRAM or CGRAM. When address information is written into the IR, then data is stored into the DR from DDRAM or CGRAM. By the register selector (RS) signal, these two registers can be selected.

RS	R/W	Operation
0	0	IR write as an internal operation (display clear, etc.)
0	1	Read busy flag (DB7) and address counter (DB0 to DB7)
1	0	Write data to DDRAM or CGRAM (DR to DDRAM or CGRAM)
1	1	Read data from DDRAM or CGRAM (DDRAM or CGRAM to DR)

Busy Flag (BF)

When the busy flag is 1, the controller LSI is in the internal operation mode, and the next instruction will not be accepted. When RS=0 and R/W=1, the busy flag is output to DB7. The next instruction must be written after ensuring that the busy flag is 0.

Address Counter (AC)

The address counter (AC) assigns addresses to both DDRAM and CGRAM

Display Data RAM (DDRAM)

This DDRAM is used to store the display data represented in 8-bit character codes. Its extended capacity is 80x8 bits or 80 characters. Below figure is the relationships between DDRAM addresses and positions on the liquid crystal display.



Example: DDRAM addresses 4E



1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20
00	01	02	03	04	05	06	07	08	09	0A	0B	0C	0D	0E	0F	10	11	12	13
40	41	42	43	44	45	46	47	48	49	4A	4B	4C	4D	4E	4F	50	51	52	53
14	15	16	17	18	19	1A	1B	1C	1D	1E	1F	20	21	22	23	24	25	26	27
54	55	56	57	58	59	5A	5B	5C	5D	5E	5F	60	61	62	63	64	65	66	67

Display position DDRAM address

4-Line by 20-Character Display

Character Generator ROM (CGROM)

The CGROM generate 5×8 dot or 5×10 dot character patterns from 8-bit character codes. See Table 2.

Character Generator RAM (CGRAM)

In CGRAM, the user can rewrite character by program. For 5×8 dots, eight character patterns can be written, and for 5×10 dots, four character patterns can be written.

Write into DDRAM the character code at the addresses shown as the left column of table 1. To show the character patterns stored in CGRAM.

9

Relationship between CGRAM Addresses, Character Codes (DDRAM) and Character patterns

Table 1.

For 5 * 8 dot character patterns

Character Codes (DDRAM data)	CGRAM Address	Character Patterns (CGRAM data)	
7 6 5 4 3 2 1 0	5 4 3 2 1 0	7 6 5 4 3 2 1 0	
High Low	High Low	High Low	
0 0 0 0 * 0 0 0	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	* * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0	Character pattern(1) Cursor pattern
0 0 0 0 * 0 0 1	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	* * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0 * * * 0 0 0	Character pattern(2)
	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	* * * 0 0 0 0 0	Cursor pattern
	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	* * *	

For 5 * 10 dot character patterns

10 dot endideter pat	• TH 5		
Character Codes (DDRAM data)	CGRAM Address	Character Patterns (CGRAM data)	
7 6 5 4 3 2 1 0	5 4 3 2 1 0	7 6 5 4 3 2 1 0	
High Low	High Low	High Low	
	0 0 0 0	* * * 0 0 0 0 0	1
	0 0 0 1	* * * 0 0 0 0 0	
	0 0 1 0	* * * 0 0	
	0 0 1 1	* * * 0 0	
	0 1 0 0	* * * 0 0 0	
0 0 0 0 * 0 0 0	0 0 0 1 0 1	* * * 0 0 0	
	0 1 1 0	* * * 0	CI
	0 1 1 1	* * * 0 0 0 0	p a
	1 0 0 0	* * * 0 0 0 0	
	1 0 0 1	* * * 0 0 0 0	•
	1 0 1 0	* * * 0 0 0 0 0	C
		* * * * * * *	

C haracter pattern

Cursor pattern

🔳 : " High "

8. Character Generator ROM Pattern

Table 2.

Upper 4 bit	LLLL									HLLH						
Lower 4 bit	LLLL	LLLH	LLHL	LLHH	LHLL	LHLH		гннн	HLLL	HLLH	HLHL	HLHH	HHLL	HHLH	нннг	нннн
LLLL	CG RAM (1)					 :	•••					••••	-] ::::•
LLLH	(2)							-:::								
LLHL	(3)		11					₽···•				· [_:-: [‡]	 :	
LLHH	(4)					:	:					·		-	::::-	s:-:*
LHLL	(5)			÷.				·			•		.	1] I	
LHLH	(6)			:		.	::•	II			==		-			
LHHL	(7)					I		••			····				¦∭	
LHHH	(8)						•	II							·]	
HLLL	(1)						ŀ"	::::			·:[•]]			•_I	
HLLH	(2)					••		•!			•	•			1	ا <u>…</u> ا
HLHL	(3)		:-[-:	**	. I								· ·	.		:: :]
HLHH	(4)			::				÷					.		:•:]=1
HHLL	(5)		:=								·]::		·!	·	·: ! :-	
HHLH	(6)						[**]						••••	 ⁼	: ! :	:
HHHL	(7)				ŀ		!*"'I	:					•	••*•	ŀ	
НННН	(8)			•				- <u></u>			:::	•	••:		ıı	

9. Instruction Table

Instruction				Ins	struct	ion Co	ode				Description	Execution time
	RS	R/W	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0		(fosc=270Khz)
Clear Display	0	0	0	0	0	0	0	0	0	1	Write "00H" to DDRAM and set DDRAM address to "00H" from AC	1.53ms
Return Home	0	0	0	0	0	0	0	0	1	-	Set DDRAM address to "00H" from AC and return cursor to its original position if shifted. The contents of DDRAM are not changed.	1.53ms
Entry Mode Set	0	0	0	0	0	0	0	1	I/D	SH	Assign cursor moving direction and enable the shift of entire display.	39 µ s
Display ON/OFF Control	0	0	0	0	0	0	1	D	С	В	Set display (D), cursor (C), and blinking of cursor (B) on/off control bit.	39 µ s
Cursor or Display Shift	0	0	0	0	0	1	S/C	R/L	-	-	Set cursor moving and display shift control bit, and the direction, without changing of DDRAM data.	39 µ s
Function Set	0	0	0	0	1	DL	N	F	-	-	Set interface data length (DL:8-bit/4-bit), numbers of display line (N:2-line/1- line)and, display font type (F:5×11 dots/5×8 dots)	39 µ s
Set CGRAM Address	0	0	0	1	AC5	AC4	AC3	AC2	AC1	AC0	Set CGRAM address in address counter.	39 µ s
Set DDRAM Address	0	0	1	AC6	AC5	AC4	AC3	AC2	AC1	AC0	Set DDRAM address in address counter	39 µ s
Read Busy Flag and Address	0	1	BF	AC6	AC5	AC4	AC3	AC2	AC1	AC0	Whether during internal operation or not can be known by reading BF. The contents of address counter can also be read.	0 µ s
Write Data to RAM	1	0	D7	D6	D5	D4	D3	D2	D1	D0	Write data into internal RAM (DDRAM/CGRAM).	43 µ s
Read Data from RAM	1	1	D7	D6	D5	D4	D3	D2	D1	D0	Read data from internal RAM (DDRAM/CGRAM).	43 µ s

* "-": don't care

10. Timing Characteristics

10.1 Write Operation

Writing data from MPU



			10-2		0.01
Item	Symbol	Min	Тур	Max	Unit
Enable cycle time	T _c	1200	-	-	ns
Enable pulse width	T _{PW}	140	-	-	ns
Enable rise/fall time	T _R ,T _F	-	-	25	ns
Address set-up time (RS, R/W to E)	t _{AS}	0	-	-	ns
Address hold time	t _{AH}	10	-	-	ns
Data set-up time	t _{DSW}	40	-	-	ns
Data hold time	t _H	10	-	-	ns

10.2 Read Operation

• Reading data from ST7066U



Ta=25℃, VDD=5V

				 ,	
Item	Symbol	Min	Тур	Max	Unit
Enable cycle time	Тc	1200	-	-	ns
Enable pulse width(high level)	T _{PW}	140	-	-	ns
Enable rise/fall time	T _R ,T _F	-	-	25	ns
Address set-up time (RS, R/W to E)	t _{AS}	0	-	-	ns
Address hold time	t _{AH}	10	-	-	ns
Data delay time	t _{DDR}	-	-	100	ns
Data hold time	t _H	10	-	-	ns

11. Initializing of LCM

				Powe	er on					
Wai	it for	more	than 4	40 ms	after	Vddt	ises t	o 4.5	V	
					1					BF can not be checked before this instruction.
					DB4	DB3 *	DB2 *	DB1 *	DB0 *	Function set
0	0	0	0	1	1	r	Ŷ	ŕ	ŕ	
		V	Vait fo	or mor	re thar	n 39us	3			
										BF can not be checked before this instruction.
					DB4					Function set
0	0	0 N	0 F	1 *	0 *	*	*	*	*	
	0	TN	1		1					
		V	Vait fo	or moi	re thar	1 39 µ	ls			
RS	R/W	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0	BF can not be checked before this instruction.
0	0	0	0	1	0	*	*	*	*	Function set
0	0	N	F	*	*	*	*	*	*	
		V	Vait fo	or mor	re thar	1 37us	3			
RS I	$\frac{R/W}{0}$	$\frac{\text{DB7}}{0}$	$\frac{\text{DB6}}{0}$	$\frac{\text{DB5}}{0}$	DB4 0	<u>DB3</u> *	<u>DB2</u> *	<u>DB1</u> *	<u>DB0</u>	Display ON/OFF control
0	0	1	D	0 C	<u>в</u>	*	*	*	*	
		-	2							
		V	Vait fo	or mor	re thar	1 37 µ	IS			
RS]	R/W	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0	Directory Charg
0	0	0	0	0	0	*	*	*	*	Display Clear
0	0	0	0	0	1	*	*	*	*	
			Joit f		re thar	1.50	1226			
		V		or moi	e inar	11.55	ms			
RS	D/W	DD7			DB4	002	002	ותם	DDO	
$\frac{\mathbf{KS}}{0}$	$\frac{K}{W}$	$\frac{DB}{0}$	0	0	$\frac{DB4}{0}$	*	<u>DB2</u> *	*	*	Entry Mode Set
0	0	0	1	I/D	SH	*	*	*	*	
			Initia	alizati	on end	ds				
L										

4-Bit Ineterface



8-Bit Ineterface

12. Reliability

Content of Reliability Test (w	vide temperature, -20°C ~70°C)
--------------------------------	--------------------------------

	Environmental Test							
Test Item	Content of Test	Test Condition	Note					
High Temperature storage	Endurance test applying the high storage temperature for a long time.	80°C 200hrs	2					
Low Temperature storage	Endurance test applying the high storage temperature for a long time.	-30°C 200hrs	1,2					
High Temperature Operation	Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time.	70°C 200hrs						
Low Temperature Operation	Endurance test applying the electric stress under low temperature for a long time.	-20°C 200hrs	1					
High Temperature/ Humidity Operation	The module should be allowed to stand at 60 °C,90%RH max For 96hrs under no-load condition excluding the polarizer, Then taking it out and drying it at normal temperature.	60°C ,90%RH 96hrs	1,2					
Thermal shock resistance	The sample should be allowed stand the following 10 cycles of operation $-20^{\circ}C$ $25^{\circ}C$ $70^{\circ}C$ 30min 5min 30min 1 cycle	-20°C/70°C 10 cycles						
Vibration test	Endurance test applying the vibration during transportation and using.	Total fixed amplitude : 1.5mm Vibration Frequency : 10~55Hz One cycle 60 seconds to 3 directions of X,Y,Z for Each 15 minutes	3					
Static electricity test	Endurance test applying the electric stress to the terminal.	VS=800V,RS=1.5kΩ CS=100pF 1 time						

Note1: No dew condensation to be observed.

Note3: Vibration test will be conducted to the product itself without putting it in a container.

Note2: The function test shall be conducted after 4 hours storage at the normal Temperature and humidity after remove from the test chamber.

13. Backlight Information

Specification

PARAMETER	SYMBOL	MIN	ТҮР	MAX	UNIT	TEST CONDITION	
Supply Current	ILED	224	280	420	mA	V=4.2V	
Supply Voltage	V	3.9	4.2	4.4	V	-	
Reverse Voltage	VR	-	-	10	V	-	
Luminous Intensity	IV	200	260	-	CD/M ²	ILED=280mA	
Wave Length	λρ	560	570	580	nm	ILED=280mA	
Life Time	-	-	100000		Hr.	ILED≪280mA	
Color	Yellow Green						

Note: The LED of B/L is drive by current only, drive voltage is for reference only.drive voltage can make driving current under safety area (current between minimum and maximum).

Note 1:50K hours is only an estimate for reference.

2.Drive from pin15,pin16



ill never get Vee output from pin15)

14. Inspection specification

NO	Item	Criterion						
01	Electrical Testing	 1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character , dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 LCD viewing angle defect. 1.7 Mixed product types. 1.8 Contrast defect. 						
02	Black or white spots on LCD (display only)	 2.1 White and black spots on display ≤0.25mm, no more than three white or black spots present. 2.2 Densely spaced: No more than two spots or lines within 3mm 						
03	LCD black spots, white spots, contamination	3.1 Round type : Φ=(x + y)/ 3.2 Line type : (4)	2 Y	SIZE $\Phi \leq 0.10$ $0.10 < \Phi \leq 0.20$ $0.20 < \Phi \leq 0.25$ $0.25 < \Phi$	2	2.5		
	(non-display)		Length L≦3.0 L≦2.5 	Width $W \leq 0.02$ $0.02 < W \leq 0.03$ $0.03 < W \leq 0.05$ $0.05 < W$	Acceptable Q TY Accept no dense 2 As round type	2.5		
04	Polarizer bubbles	If bubbles are vis judge using black specifications, no to find, must che specify direction	k spot ot easy ck in	Size Φ $\Phi \le 0.20$ $0.20 < \Phi \le 0.50$ $0.50 < \Phi \le 1.00$ $1.00 < \Phi$ Total Q TY	Acceptable Q TY Accept no dense 3 2 0 3 3	2.5		

NO	Item		Criterion		AÇ
05	Scratches	Follow NO.3 LCD bla	ck spots, white spots, cont	amination	
		k: Seal width tL: Electrode pad lengt6.1 General glass chip	t: Glass thickness a: LCD h:	o thickness O side length anels:	
			- Thy		
	Chipped	z: Chip thickness $7 \le 1/2t$	y: Chip width	x: Chip length $x \le 1/8$	
06	Chipped glass	$\begin{array}{c} Z \leq 1/2t \\ 1/2t < z \leq 2t \end{array}$	Not over viewing area Not exceed 1/3k	$x \le 1/8a$ $x \le 1/8a$	2.5
06		$\begin{array}{c} Z \leq 1/2t \\ 1/2t < z \leq 2t \end{array}$	Not over viewing area	$x \le 1/8a$ $x \le 1/8a$	2.5
06		$Z \le 1/2t$ $1/2t < z \le 2t$ \odot If there are 2 or more6.1.2 Corner crack:If there are 2 or moreZ Corner crack:If there are 2 or moreCorner crack:	Not over viewing area Not exceed 1/3k e chips, x is total length of e y: Chip width	x≤1/8a x≤1/8a ach chip. x: Chip length	2.5
06		$Z \leq 1/2t$ $1/2t < z \leq 2t$ $\odot If there are 2 or more$ $6.1.2 Corner crack:$	Not over viewing area Not exceed 1/3k e chips, x is total length of e	$x \le 1/8a$ $x \le 1/8a$ ach chip.	2.5

Rev 00



NO	Item	Criterion	AQL
07	Cracked glass	The LCD with extensive crack is not acceptable.	2.5
08	Backlight elements	 8.1 Illumination source flickers when lit. 8.2 Spots or scratched that appear when lit must be judged. Using LCD spot, lines and contamination standards. 8.3 Backlight doesn't light or color wrong. 	0.65 2.5 0.65
09	Bezel	9.1 Bezel may not have rust, be deformed or have fingerprints, stains or other contamination.9.2 Bezel must comply with job specifications.	2.5 0.65
10	PCB · COB	 10.1 COB seal may not have pinholes larger than 0.2mm or contamination. 10.2 COB seal surface may not have pinholes through to the IC. 10.3 The height of the COB should not exceed the height indicated in the assembly diagram. 10.4 There may not be more than 2mm of sealant outside the seal area on the PCB. And there should be no more than three places. 10.5 No oxidation or contamination PCB terminals. 10.6 Parts on PCB must be the same as on the production characteristic chart. There should be no wrong parts, missing parts or excess parts. 10.7 The jumper on the PCB should conform to the product characteristic chart. 10.8 If solder gets on bezel tab pads, LED pad, zebra pad or screw hold pad, make sure it is smoothed down. 10.9 The Scraping testing standard for Copper Coating of PCB 	 2.5 2.5 0.65 2.5 0.65 0.65 2.5 2.5 2.5 2.5
11	Soldering	 11.1 No un-melted solder paste may be present on the PCB. 11.2 No cold solder joints, missing solder connections, oxidation or icicle. 11.3 No residue or solder balls on PCB. 	2.5 2.5 2.5

11.4 No short circuits in components on PCB.	0.65
	,

NO	Item	Criterion			
NO 12	Item General appearance	 12.1 No oxidation, contamination, curves or, bends on interface Pin (OLB) of TCP. 12.2 No cracks on interface pin (OLB) of TCP. 12.3 No contamination, solder residue or solder balls on product. 12.4 The IC on the TCP may not be damaged, circuits. 12.5 The uppermost edge of the protective strip on the interface pin must be present or look as if it cause the interface pin to sever. 12.6 The residual rosin or tin oil of soldering (component or chip component) is not burned into brown or black color. 12.7 Sealant on top of the ITO circuit has not hardened. 12.9 LCD pin loose or missing pins. 12.10 Product packaging must the same as specified on packaging specification sheet. 	AQL 2.5 0.65 2.5 2.5 2.5 2.5 2.5 2.5 2.5 0.65 0.65 0.65		
		12.11 Product dimension and structure must conform to product specification sheet.	0.65		

15. Material List of Components for RoHs

1.We hereby declares that all of or part of products, including but not limited to, the LCM, accessories or packages, manufactured and/or delivered to your company (including your subsidiaries and affiliated company) directly or indirectly by our company (including our subsidiaries or affiliated companies) do not intentionally contain any of the substances listed in all applicable EU directives and regulations, including the following substances.

Exhibit A : The Harmful Material List

Material	(Cd)	(Pb)	(Hg)	(Cr6+)	PBBs	PBDEs		
Limited Value	100 ppm	1000 ppm						
Above limited value is set up according to RoHS.								

2.Process for RoHS requirement :

- (1) Use the Sn/Ag/Cu soldering surface ; the surface of Pb-free solder is rougher than we used before.
- (2) Heat-resistance temp. :

Reflow : 250°C,30 seconds Max. ;

Connector soldering wave or hand soldering : 320°C, 10 seconds max.

(3) Temp. curve of reflow, max. Temp. : 235 \pm 5 $^{\circ}$ C ;

Recommended customer's soldering temp. of connector : 280° C, 3 seconds.